

Search Notes



Application/Control No.

10/800,195

Examiner

Sin J. Lee

Applicant(s)/Patent under Reexamination

DAI ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	270.1	4-3-05	SJL
↓	905	↓	↓
↓	313	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR